

# TSD65R380WT/TSU65R380WT

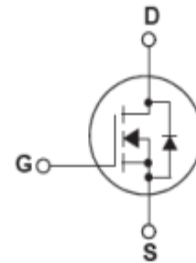
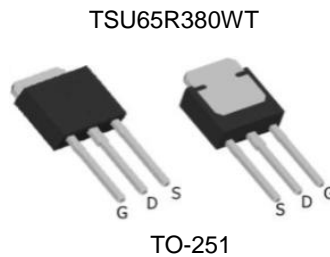
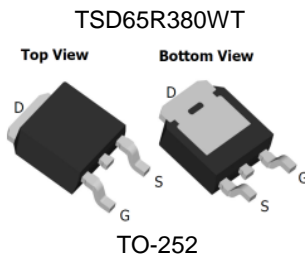
## 650V 11A N-Channel SJ-MOSFET

### General Description

Truesemi SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance. This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.

### Features

- 700V @T<sub>J</sub> = 150 °C
- Max. RDS(on) = 0.38Ω
- Ultra Low gate charge (typ. Q<sub>g</sub> = 17.5nC)
- 100% avalanche tested



### Absolute Maximum Ratings

T<sub>C</sub>=25°C unless otherwise specified

Symbol	Parameter	Value	Unit
V <sub>DSS</sub>	Drain-Source Voltage	650	V
I <sub>D</sub>	Drain Current -Continuous (T <sub>C</sub> = 25°C) -Continuous (T <sub>C</sub> = 100°C)	11 7	A
I <sub>DM</sub>	Drain Current – Pulsed (Note 1)	33	A
V <sub>GSS</sub>	Gate-Source voltage	±30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	270	mJ
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) * Power Dissipation (T <sub>C</sub> = 25°C)	2.5 83	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150	°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds	300	°C

### Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case	--	1.5	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient*	--	50	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction-to-Ambient	--	110	°C/W

\* When mounted on the minimum pad size recommended (PCB Mount).

# Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A,$	650	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 650V, V_{GS} = 0V$ $T_J = 25^\circ\text{C}$	--	--	10	$\mu A$
		$V_{DS} = 520V, V_{GS} = 0V$ $T_J = 125^\circ\text{C}$	--	--	100	$\mu A$
$I_{GSS}$	Gate-Body Leakage Current,	$V_{GS} = \pm 30V, V_{DS} = 0V$	--	--	$\pm 100$	nA
<b>On Characteristics</b>						
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	2.0	--	4.0	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10V, I_D = 3.2A$	--	0.33	0.38	$\Omega$
<b>Dynamic Characteristics</b>						
$C_{ISS}$	Input Capacitance	$V_{DS} = 50V, V_{GS} = 0V,$ $f = 1.0\text{MHz}$	--	900	1170	pF
$C_{OSS}$	Output Capacitance		--	54	70	pF
$C_{RSS}$	Reverse Transfer Capacitance		--	7.0	9.5	pF
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Delay Time	$V_{DS} = 325V, I_D = 11A$ $R_G = 25\Omega$	--	30	70	ns
$t_r$	Turn-On Rise Time		--	17	44	ns
$t_{d(off)}$	Turn-Off Delay Time		--	70	150	ns
$t_f$	Turn-Off Fall Time		--	17	44	ns
$Q_g$	Total Gate Charge	$V_{DS} = 520V, I_D = 11A$ $V_{GS} = 10V$	--	17.5	23	nC
$Q_{gs}$	Gate-Source Charge		--	5.0	--	nC
$Q_{gd}$	Gate-Drain Charge		--	5.5	--	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current		--	--	11	A
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current		--	--	33	A
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0V, I_F = 11A$	--	--	1.4	V
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0V, I_F = 11A$ $di_F/dt = 100A/\mu s$	--	220	--	ns
$Q_{rr}$	Reverse Recovery Charge		--	2.0	--	$\mu C$

### NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $I_{AS}=3.5A, V_{DD}=50V, R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$
3. Pulse Test: Pulse width  $\leq 300\mu s$ , Duty Cycle  $\leq 2\%$

# Typical Performance Characteristics

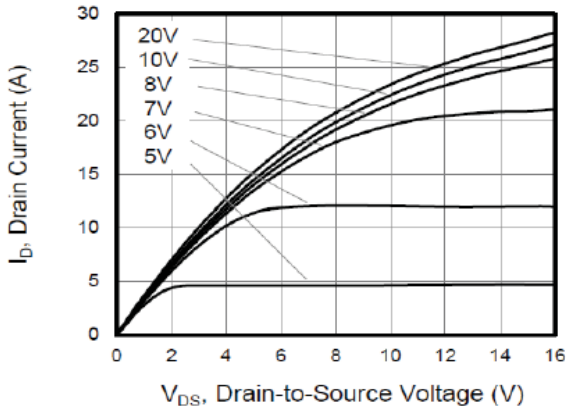


Figure 1. On Region Characteristics

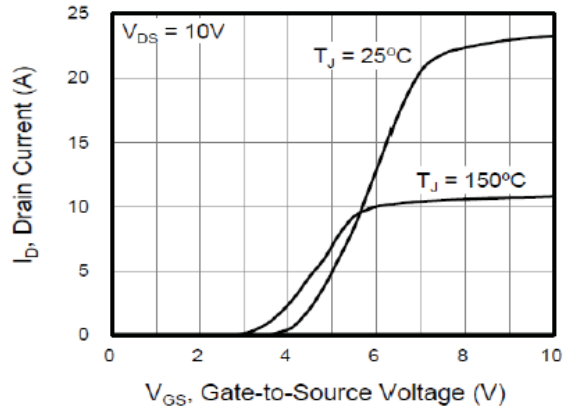


Figure 2. Transfer Characteristics

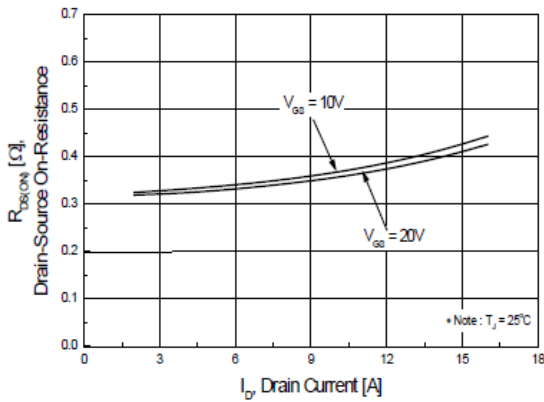


Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage

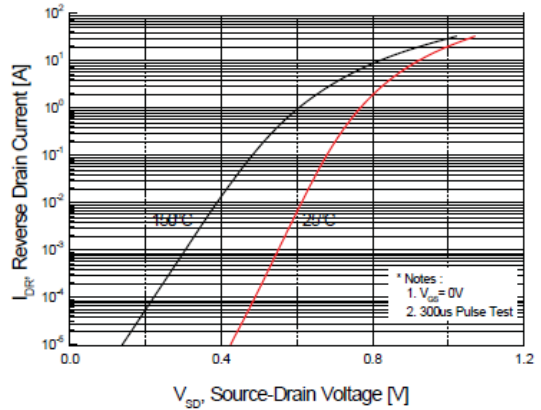


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

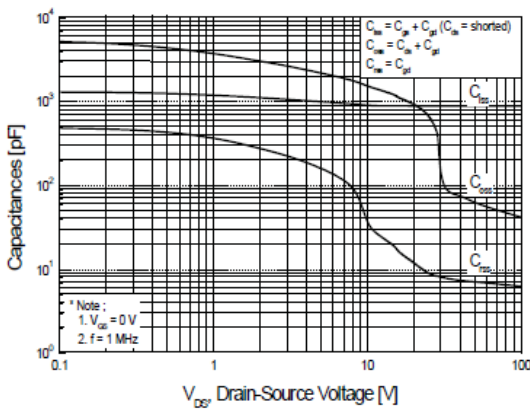


Figure 5. Capacitance Characteristics

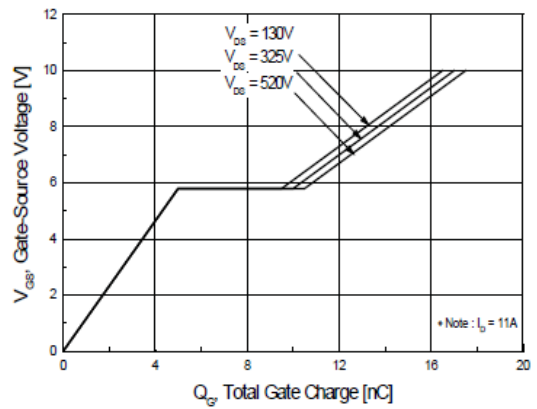
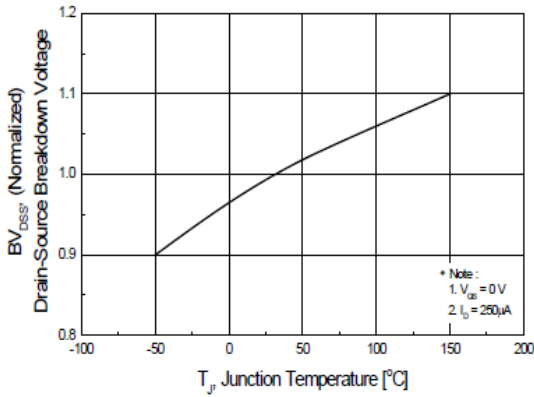
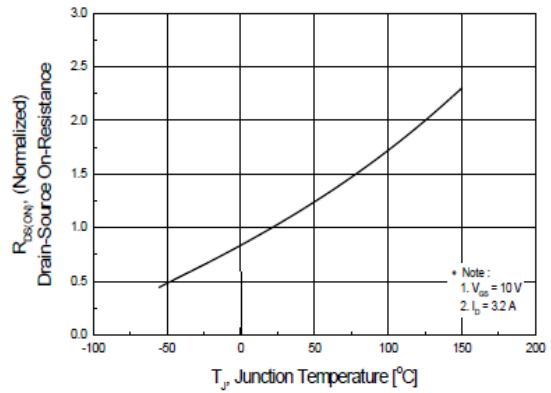


Figure 6. Gate Charge Characteristics

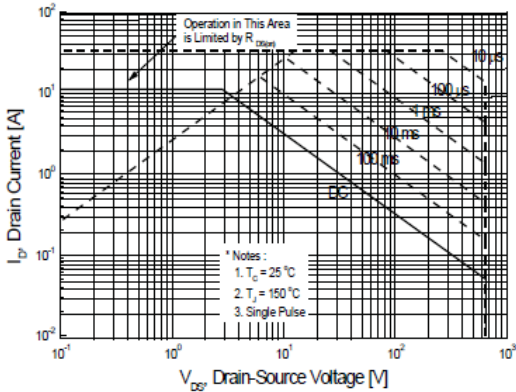
# Typical Performance Characteristics



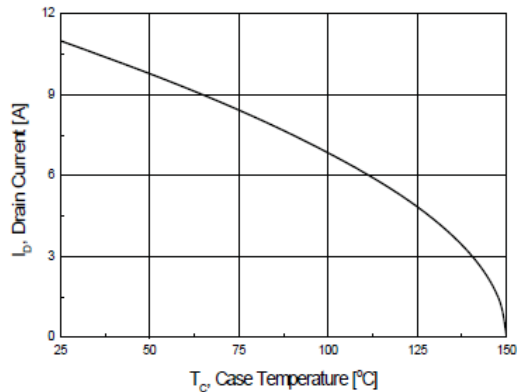
**Figure 7. Breakdown Voltage Variation vs Temperature**



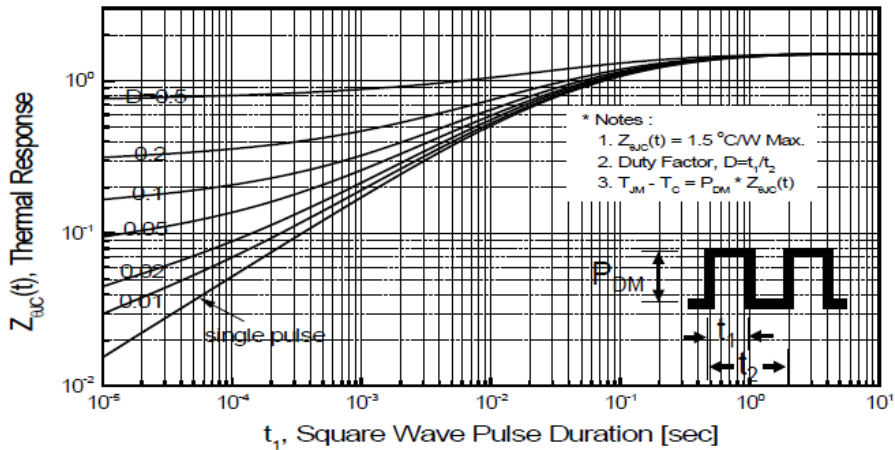
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**



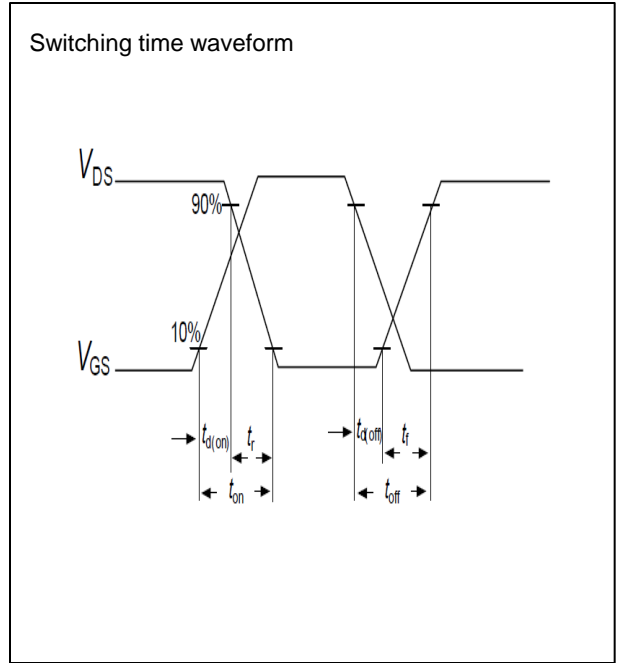
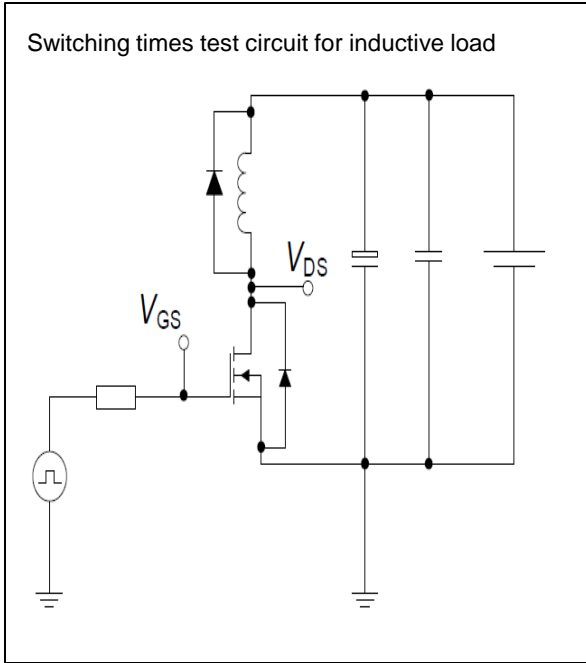
**Figure 10. Maximum Drain Current vs Case Temperature**



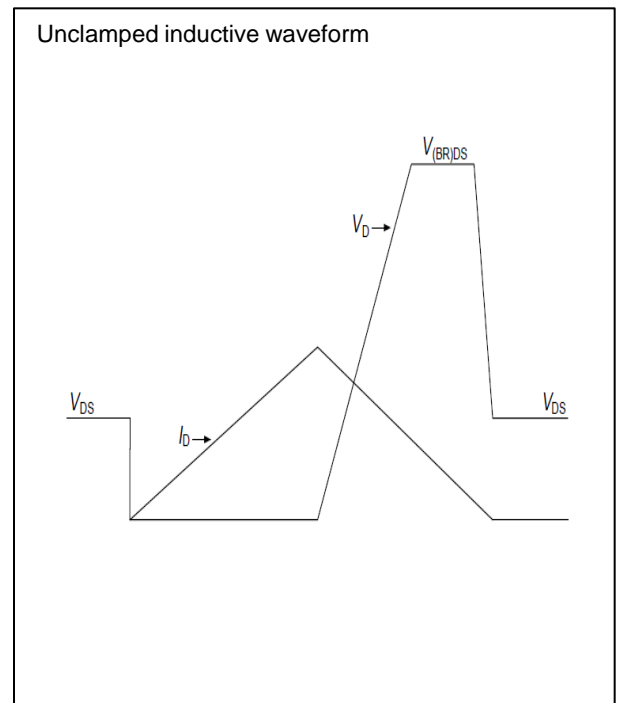
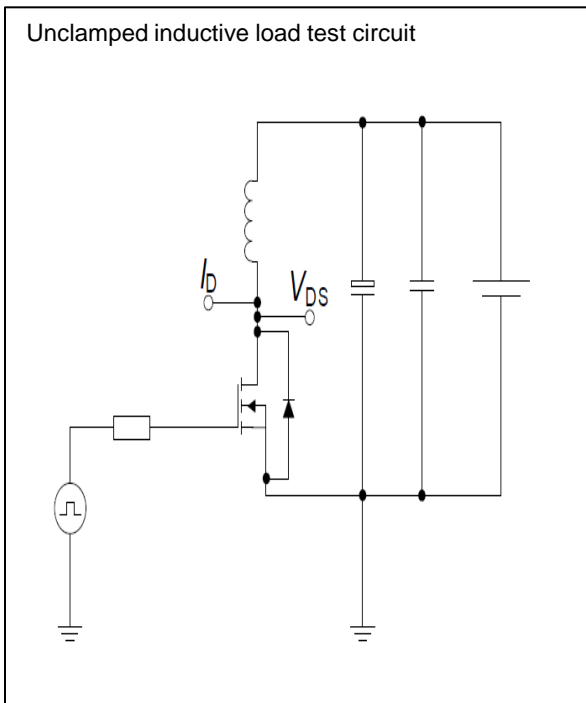
**Figure 11. Transient Thermal Response Curve**

# Test circuits

## Switching times test circuit and waveform for inductive load

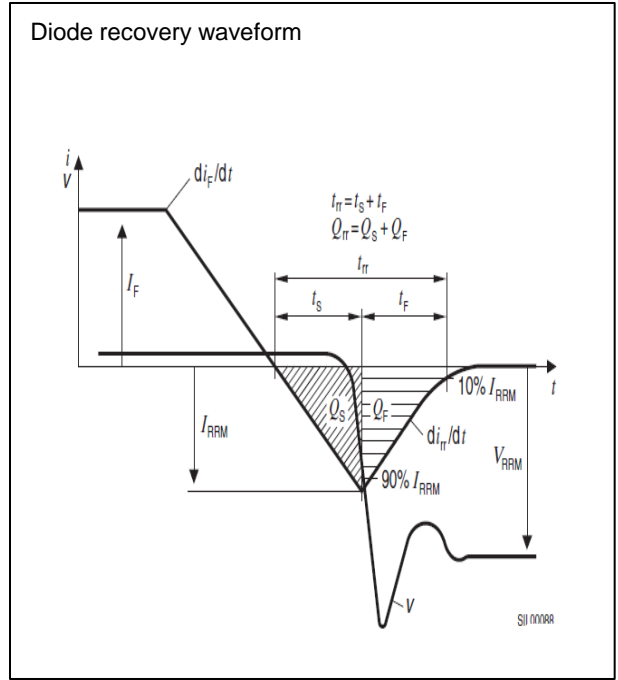
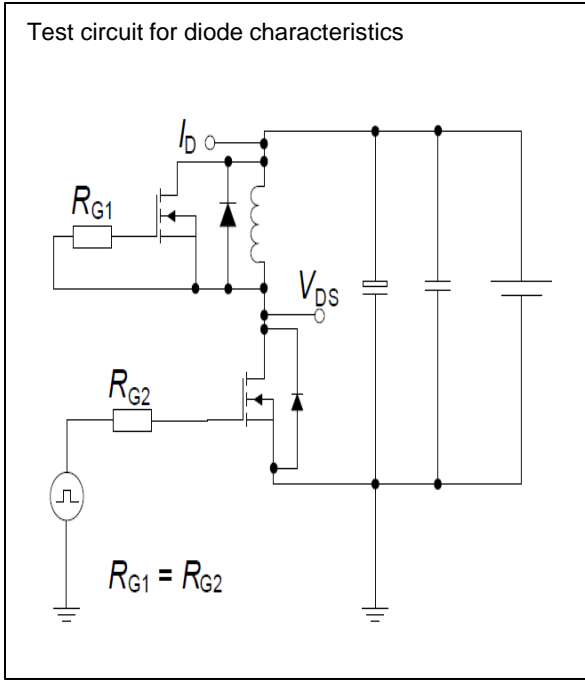


## Unclamped inductive load test circuit and waveform



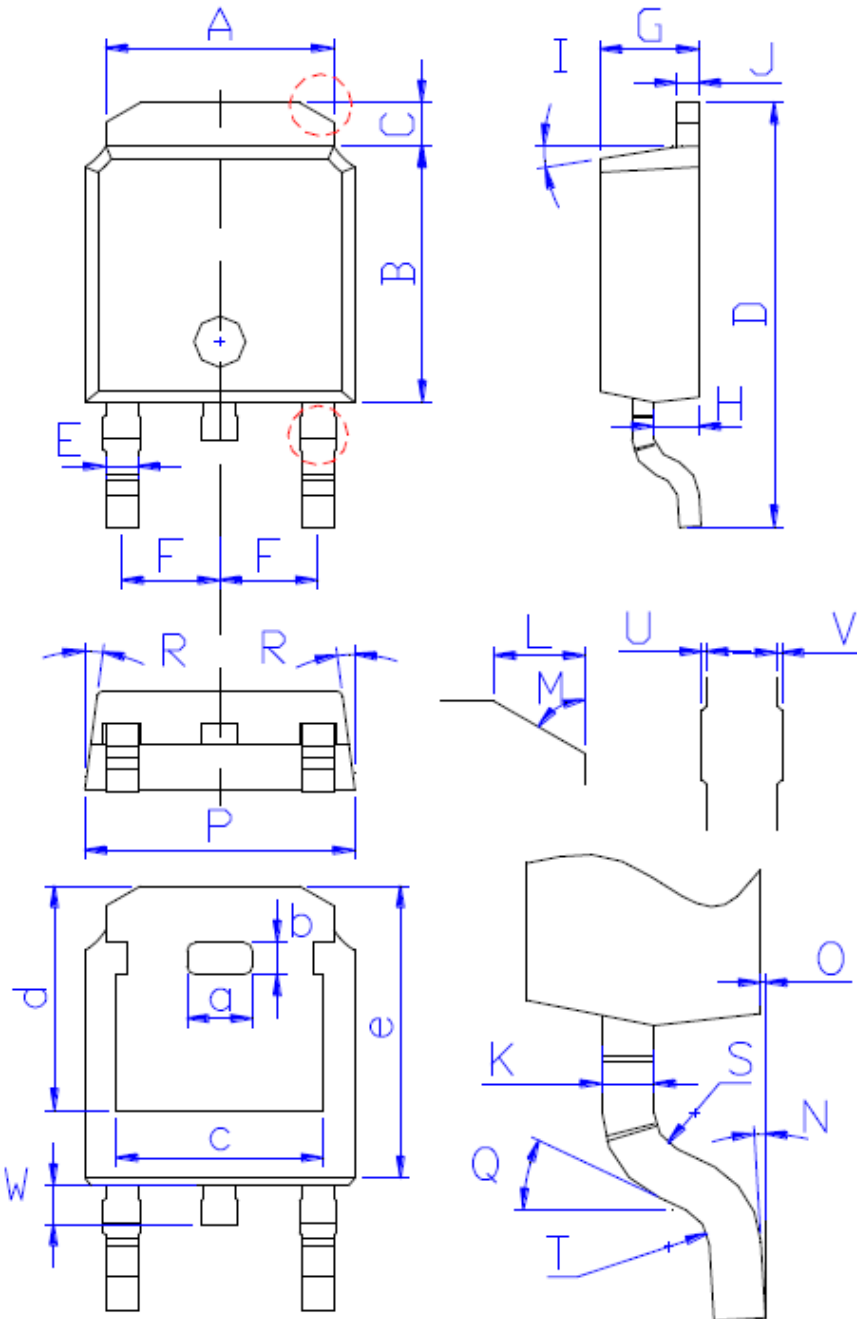
# Test circuits

## Test circuit and waveform for diode characteristics



# Package Outline TO-252

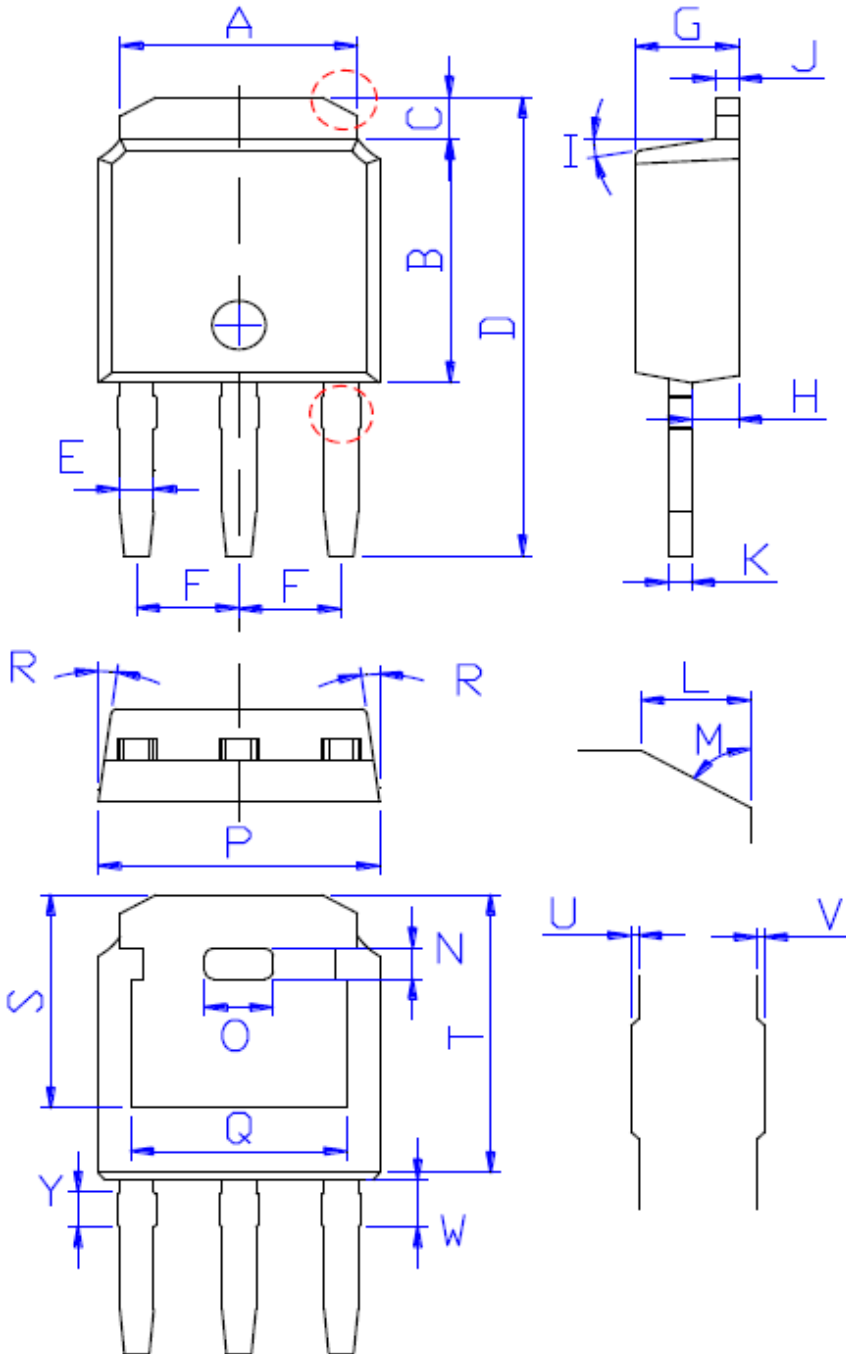
TSD65R380WT/TSU65R380WT 650V 11A N-Channel SJ-MOSFET



DIM	MILLIMETERS
A	$5.34 \pm 0.30$
B	$6.00 \pm 0.30$
C	$1.05 \pm 0.30$
D	$9.95 \pm 0.30$
E	$0.76 \pm 0.15$
F	$2.28 \pm 0.15$
G	$2.30 \pm 0.30$
H	$1.06 \pm 0.30$
I	$(4-10)^\circ$
J	$0.51 \pm 0.15$
K	$0.52 \pm 0.15$
L	$0.80 \pm 0.30$
M	$60^\circ$
N	$(0-10)^\circ$
O	$0.05 \pm 0.05$
P	$6.60 \pm 0.30$
Q	$25^\circ$
R	$(4-8.5)^\circ$
S	R0.40
T	R0.40
U	$0.05 \pm 0.05$
V	$0.05 \pm 0.05$
W	$0.90 \pm 0.30$
a	$1.80 \pm 0.30$
b	$0.75 \pm 0.30$
c	$4.85 \pm 0.30$
d	$5.30 \pm 0.30$
e	$6.90 \pm 0.30$

# Package Outline TO-251

TSD65R380WT/TSU65R380WT 650V 11A N-Channel SJ-MOSFET



DIM	MILLIMETERS
A	5.34±0.30
B	6.00±0.30
C	1.05±0.30
D	11.31±0.30
E	0.76±0.15
F	2.28±0.15
G	2.30±0.30
H	1.06±0.30
I	(4-10)°
J	0.51±0.15
K	0.52±0.15
L	0.80±0.30
M	60°
N	0.75±0.30
O	1.80±0.30
P	6.60±0.30
Q	4.85±0.30
R	(4-8.5)°
S	5.30±0.30
T	6.90±0.30
U	0.05±0.05
V	0.05±0.05
W	1.15±0.25
Y	0.85±0.25